

### FRED Ultrafast Soft Recovery Diode, 30 A

#### FEATURES

- Ultrafast recovery
- 175 °C operating junction temperature
- Designed and qualified for industrial level

#### BENEFITS

- Reduced RFI and EMI
- Higher frequency operation
- Reduced snubbing
- Reduced parts count

#### DESCRIPTION/APPLICATIONS

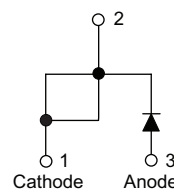
These diodes are optimized to reduce losses and EMI/RFI in high frequency power conditioning systems.

The softness of the recovery eliminates the need for a snubber in most applications. These devices are ideally suited for HF welding, power converters and other applications where switching losses are not significant portion of the total losses.

N-30EPU06

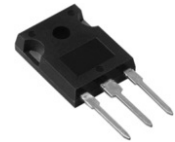


Cathode to base

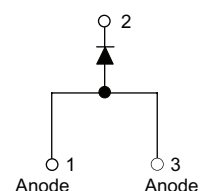


TO-247AC modified

N-30APU06



Cathode to base



TO-247AB

#### PRODUCT SUMMARY

$t_{rr}$	30 ns
$I_{F(AV)}$	30 A
$V_R$	600 V

#### ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	TEST CONDITIONS	VALUES	UNITS
Cathode to anode voltage	$V_R$		600	V
Continuous forward current	$I_{F(AV)}$	$T_C = 116\text{ °C}$	30	A
Single pulse forward current	$I_{FSM}$	$T_C = 25\text{ °C}$	300	
Operating junction and storage temperatures	$T_j, T_{Stg}$		- 55 to 175	°C

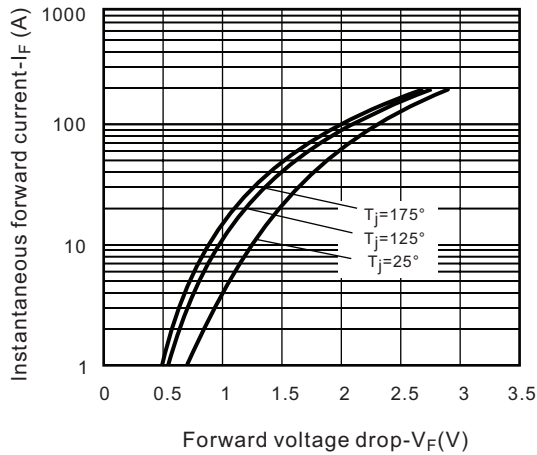
#### ELECTRICAL SPECIFICATIONS (T<sub>J</sub> = 25 °C unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Breakdown voltage, blocking voltage	$V_{BR}, V_f$	$I_R = 100\mu A$	600	-	-	V
Forward voltage	$V_F$	$I_F = 30A$	-	1.40	1.80	
		$I_F = 60A$	-	1.70	2.0	
Reverse leakage current	$I_R$	$V_R = V_R \text{ rated}$	-	-	25	$\mu A$
		$T_J = 150\text{ °C}, V_R = V_R \text{ rated}$	-	-	500	
Junction capacitance	$C_T$	$V_R = 200V$	-	35	-	pF

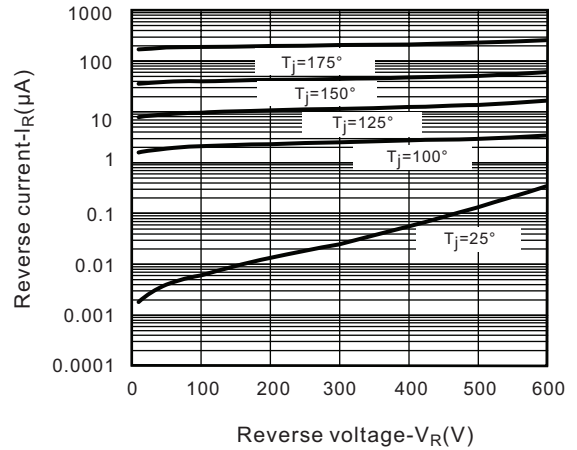
DYNAMIC RECOVERY CHARACTERISTICS (T <sub>J</sub> = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS	
Reverse recovery time	t <sub>rr</sub>	I <sub>F</sub> = 0.5A, I <sub>R</sub> = 1A, I <sub>RR</sub> = 0.25A (RG#1 CKT)	-	30	35	ns	
		I <sub>F</sub> = 1A, dI <sub>F</sub> /dt = -100 A/μs, V <sub>R</sub> = 30V, T <sub>J</sub> = 25°C	-	23	-		
		T <sub>J</sub> = 25°C	-	30	-		
		T <sub>J</sub> = 125°C	-	75	-		
Peak recovery current	I <sub>RRM</sub>	I <sub>F</sub> = 30 A dI <sub>F</sub> /dt = -200 A/μs V <sub>R</sub> = 400 V	T <sub>J</sub> = 25°C	-	3	-	A
			T <sub>J</sub> = 125°C	-	6	-	
Reverse recovery charge	Q <sub>rr</sub>		T <sub>J</sub> = 25°C	-	55	-	nC
			T <sub>J</sub> = 125°C	-	485	-	

THERMAL - MECHANICAL SPECIFICATIONS						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Thermal resistance, junction to case	R <sub>thJC</sub>		-	0.5	0.8	°C/W
Thermal resistance, case to heatsink	R <sub>thCS</sub>	Mounting surface, flat, smooth and greased	-	0.4	-	
Weight			-	5.5	-	g
			-	0.2	-	oz.
Mounting torque			0.6 (5)	-	1.2 (10)	N · m (lbf · in)
Marking device		Case style TO-247AC modified	30EPU06			
		Case style TO-247AC	30APU06			

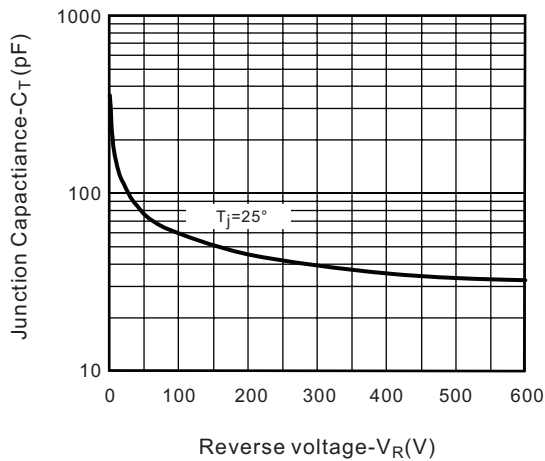
**Fig.1 Typical forward voltage drop characteristics**



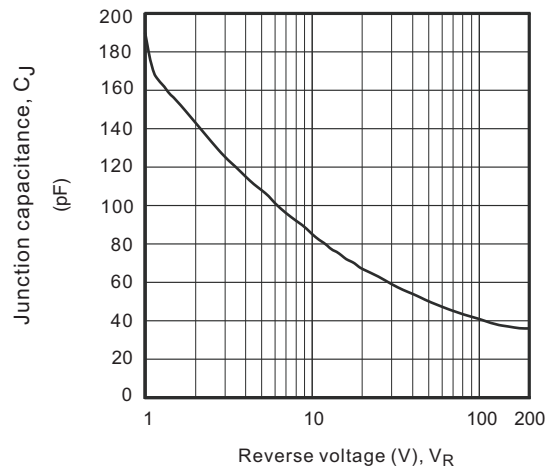
**Fig.2 Typical values of reverse current vs. reverse voltage**



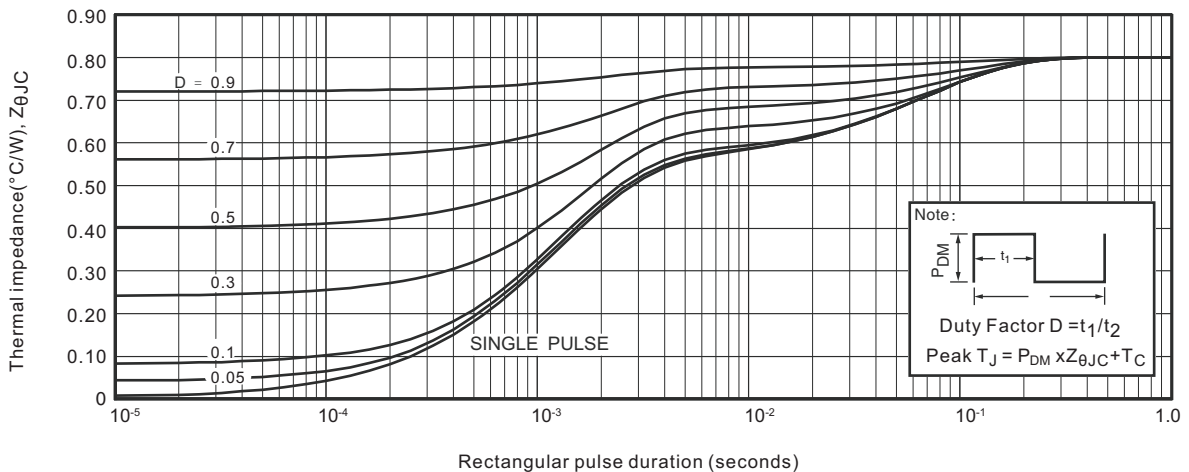
**Fig.3 Typical junction capacitance vs. reverse voltage**



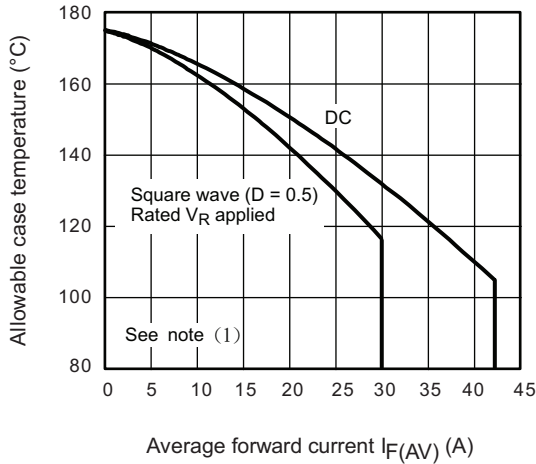
**Fig.4 Junction capacitance vs. reverse voltage**



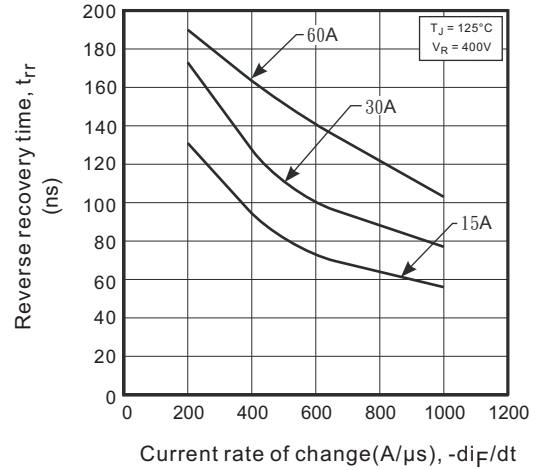
**Fig.5 Maximum effective transient thermal impedance, junction-to-case vs. pulse duration**



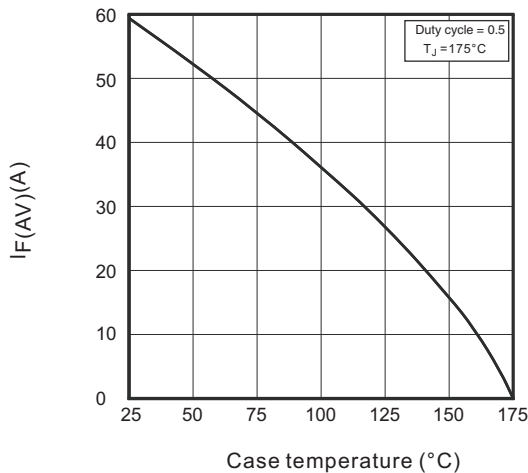
**Fig.6 Max. allowable case temperature Vs. average forward current**



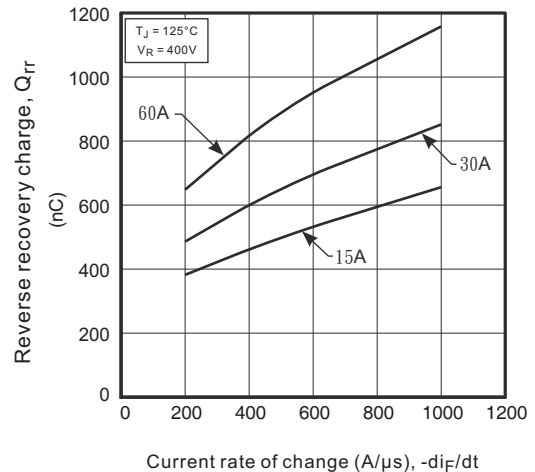
**Fig.7 Reverse recovery time vs. current rate of change**



**Fig.8 Maximum average forward current vs. case temperature**

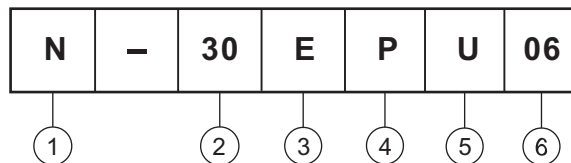


**Fig.9 Reverse recovery charge vs. current rate of change**



### Ordering Information Tabel

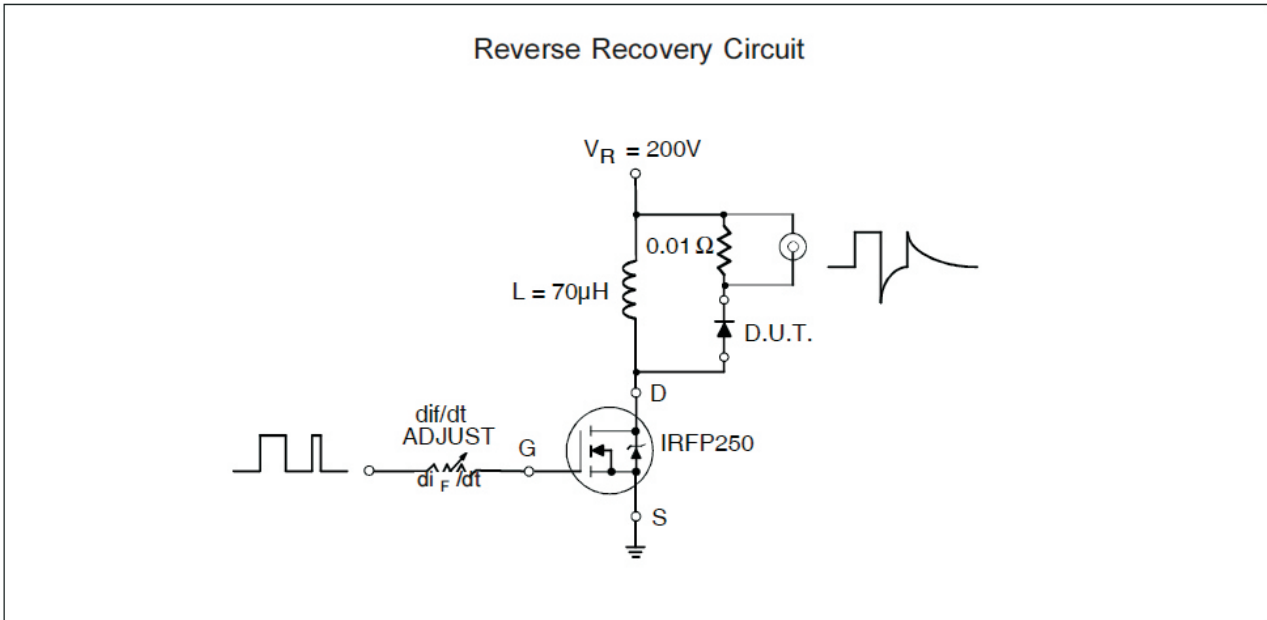
Device code



- 1 - Nell
- 2 - Current rating (30 = 30A)
- 3 - Single Diode
- 4 - TO-247AC (Modified)
- 5 - Ultrafast Recovery
- 6 - Voltage Rating (06 = 600 V)

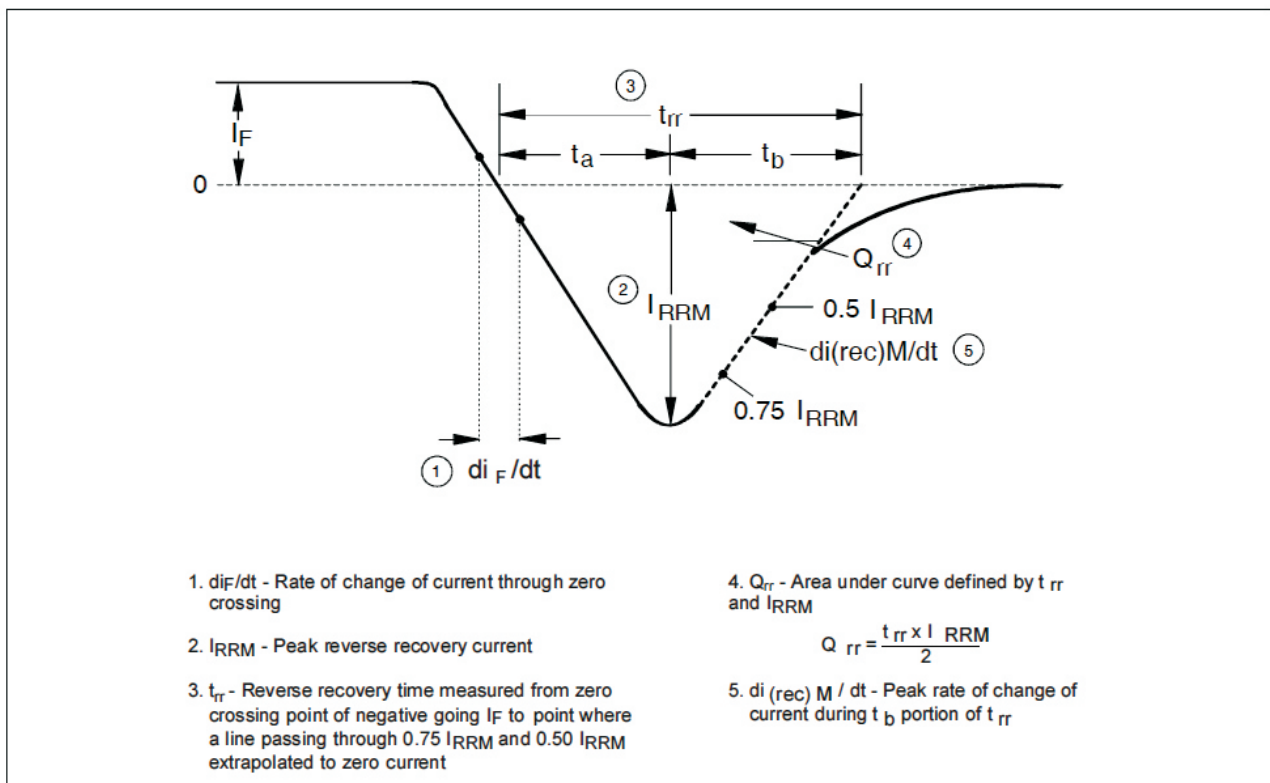
E = 2 pins  
A = 3 pins

Fig.9 Reverse recovery parameter test circuit

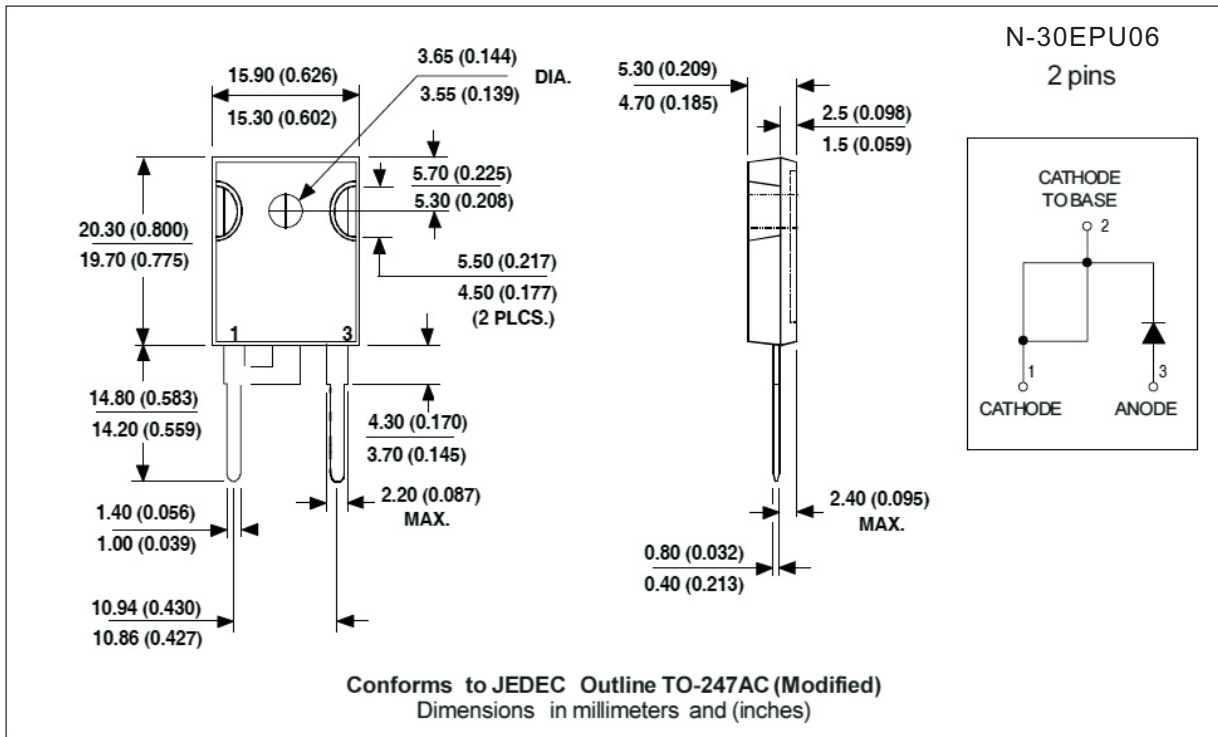


- (3) Formula used:  $T_C = T_J - (P_d + P_{d_{REV}}) \times R_{thJC}$  ;  
 $P_d = \text{Forward Power Loss} = I_{F(AV)} \times V_{FM} @ (I_{F(AV)} / D)$  (see Fig. 6);  
 $P_{d_{REV}} = \text{Inverse Power Loss} = V_{R1} \times I_R (1 - D)$ ;  $I_R @ V_{R1} = 80\%$  rated  $V_R$

Fig.10 Reverse recovery waveform and definitions



### Outline Table



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